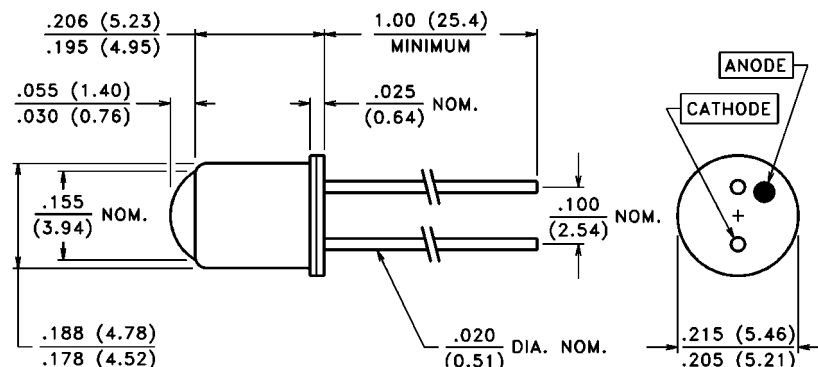




PACKAGE DIMENSIONS inch (mm)



CASE 19 TO-46 LENSED HERMETIC
CHIP ACTIVE AREA: .0025 in² (1.60 mm²)

PRODUCT DESCRIPTION

Small area planar silicon photodiode in a lensed, dual lead TO-46 package. Cathode is common to the case. These diodes have very high shunt resistance and have good blue response.

ABSOLUTE MAXIMUM RATINGS

Storage Temperature: -40°C to 110°C
Operating Temperature: -40°C to 110°C

RoHS Compliant



ELECTRO-OPTICAL CHARACTERISTICS @ 25°C (See also VTB curves, pages 13-14)

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	VTB1112H			VTB1113H			UNITS
			Min.	Typ.	Max.	Min.	Typ.	Max.	
I_{SC}	Short Circuit Current	H = 100 fc, 2850 K	30	60		30	60		μA
TC I_{SC}	I_{SC} Temperature Coefficient	2850 K		.12	.23		.12	.23	%/°C
V_{OC}	Open Circuit Voltage	H = 100 fc, 2850 K		490			490		mV
TC V_{OC}	V_{OC} Temperature Coefficient	2850 K		-2.0			-2.0		mV/°C
I_D	Dark Current	H = 0, VR = 2.0 V			100			20	pA
R_{SH}	Shunt Resistance	H = 0, V = 10 mV		.25			7.0		GΩ
TC R_{SH}	R_{SH} Temperature Coefficient	H = 0, V = 10 mV		-8.0			-8.0		%/°C
C_J	Junction Capacitance	H = 0, V = 0		.31			.31		nF
S_R	Sensitivity	365 nm		.19			.19		A/W
λ_{range}	Spectral Application Range		320		1100	320		1100	nm
λ_p	Spectral Response - Peak			920			920		nm
V_{BR}	Breakdown Voltage		2	40		2	40		V
$\theta_{1/2}$	Angular Resp. - 50% Resp. Pt.			±15			±15		Degrees
NEP	Noise Equivalent Power		3.0 x 10 ⁻¹⁴ (Typ.)			5.9 x 10 ⁻¹⁵ (Typ.)			W / √Hz
D*	Specific Detectivity		4.2 x 10 ¹² (Typ.)			2.1 x 10 ¹³ (Typ.)			cm√Hz/W